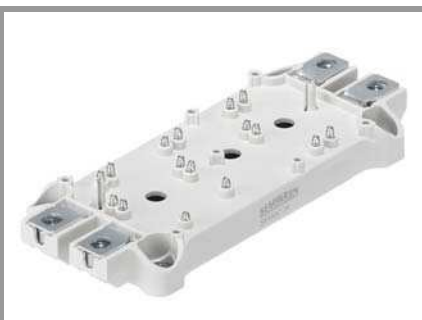


SEMiX703GAL126HDs



SEMiX® 3s

Trench IGBT Modules

SEMiX703GAL126HDs

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

Typical Applications*

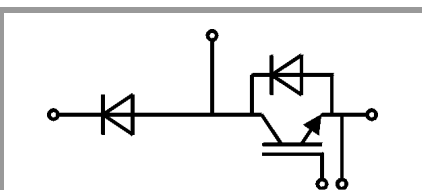
- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperatur limited to $T_C=125^\circ\text{C}$ max.
- Not for new design

Absolute Maximum Ratings					
Symbol	Conditions		Values	Unit	
IGBT					
V_{CES}	$T_j = 25^\circ\text{C}$		1200	V	
I_C	$T_j = 150^\circ\text{C}$	$T_c = 25^\circ\text{C}$	642	A	
		$T_c = 80^\circ\text{C}$	449	A	
I_{Cnom}			450	A	
I_{CRM}	$I_{CRM} = 2 \times I_{Cnom}$		900	A	
V_{GES}			-20 ... 20	V	
t_{psc}	$V_{CC} = 600\text{ V}$ $V_{GE} \leq 20\text{ V}$ $V_{CES} \leq 1200\text{ V}$	$T_j = 125^\circ\text{C}$	10		μs
T_j			-40 ... 150	$^\circ\text{C}$	
Inverse diode					
I_F	$T_j = 150^\circ\text{C}$	$T_c = 25^\circ\text{C}$	561	A	
		$T_c = 80^\circ\text{C}$	384	A	
I_{Fnom}			450	A	
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		900	A	
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2900	A	
T_j			-40 ... 150	$^\circ\text{C}$	
Freewheeling diode					
I_F	$T_j = 150^\circ\text{C}$	$T_c = 25^\circ\text{C}$	533	A	
		$T_c = 80^\circ\text{C}$	367	A	
I_{Fnom}			450	A	
I_{FRM}	$I_{FRM} = 2 \times I_{Fnom}$		900	A	
I_{FSM}	$t_p = 10\text{ ms, sin } 180^\circ, T_j = 25^\circ\text{C}$		2900	A	
T_j			-40 ... 150	$^\circ\text{C}$	
Module					
$I_{t(RMS)}$	$T_{terminal} = 80^\circ\text{C}$		600	A	
T_{stg}			-40 ... 125	$^\circ\text{C}$	
V_{isol}	AC sinus 50Hz, $t = 1\text{ min}$		4000	V	

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
IGBT						
$V_{CE(sat)}$	$I_C = 450\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.7	2.10		V
		$T_j = 125^\circ\text{C}$	2.0	2.45		V
V_{CE0}	chipelevel	$T_j = 25^\circ\text{C}$	1	1.2		V
		$T_j = 125^\circ\text{C}$	0.9	1.1		V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^\circ\text{C}$	1.6	2.0		$\text{m}\Omega$
		$T_j = 125^\circ\text{C}$	2.4	3.0		$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 18\text{ mA}$		5	5.8	6.5	V
I_{CES}	$V_{GE} = 0\text{ V}$ $V_{CE} = 1200\text{ V}$	$T_j = 25^\circ\text{C}$			5	mA
		$T_j = 125^\circ\text{C}$				mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$			32.3	nF
C_{oes}		$f = 1\text{ MHz}$			1.69	nF
C_{res}		$f = 1\text{ MHz}$			1.46	nF
Q_G	$V_{GE} = -8\text{ V...} + 15\text{ V}$				3600	nC
R_{Gint}	$T_j = 25^\circ\text{C}$				1.67	Ω



GAL

SEMiX703GAL126HDs



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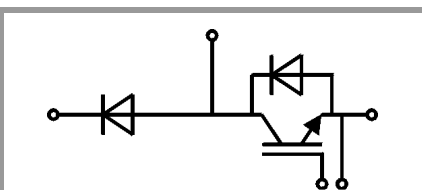
Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Not for new design

Characteristics						
Symbol	Conditions		min.	typ.	max.	Unit
$t_{d(on)}$	$V_{CC} = 600\text{ V}$	$T_j = 125^\circ\text{C}$		310		ns
t_r	$I_C = 450\text{ A}$	$T_j = 125^\circ\text{C}$		60		ns
E_{on}	$V_{GE} = \pm 15\text{ V}$	$T_j = 125^\circ\text{C}$		32		mJ
$t_{d(off)}$	$R_{G\ on} = 1.6\ \Omega$	$T_j = 125^\circ\text{C}$		680		ns
t_f	$R_{G\ off} = 1.6\ \Omega$	$T_j = 125^\circ\text{C}$		135		ns
E_{off}		$T_j = 125^\circ\text{C}$		68		mJ
$R_{th(j-c)}$	per IGBT				0.061	K/W
Inverse diode						
$V_F = V_{EC}$	$I_F = 450\text{ A}$	$T_j = 25^\circ\text{C}$		1.6	1.80	V
	$V_{GE} = 0\text{ V}$ chipelevel	$T_j = 125^\circ\text{C}$		1.6	1.8	V
V_{F0}	chipelevel	$T_j = 25^\circ\text{C}$	0.9	1	1.1	V
		$T_j = 125^\circ\text{C}$	0.7	0.8	0.9	V
r_F	chipelevel	$T_j = 25^\circ\text{C}$	1.1	1.3	1.6	m Ω
		$T_j = 125^\circ\text{C}$	1.6	1.8	2.0	m Ω
I_{RRM}	$I_F = 450\text{ A}$	$T_j = 125^\circ\text{C}$		580		A
Q_{rr}	$di/dt_{off} = 8500\text{ A}/\mu\text{s}$	$T_j = 125^\circ\text{C}$		130		μC
E_{rr}	$V_{GE} = -15\text{ V}$	$T_j = 125^\circ\text{C}$		60		mJ
$R_{th(j-c)}$	per diode				0.11	K/W
	$V_{CC} = 600\text{ V}$	$T_j = 125^\circ\text{C}$				
Freewheeling diode						
$V_F = V_{EC}$	$I_F = 450\text{ A}$	$T_j = 25^\circ\text{C}$		1.7	1.91	V
	$V_{GE} = 0\text{ V}$ chipelevel	$T_j = 125^\circ\text{C}$		1.7	1.9	V
V_{F0}	chipelevel	$T_j = 25^\circ\text{C}$	0.9	1	1.1	V
		$T_j = 125^\circ\text{C}$	0.7	0.8	0.9	V
r_F	chipelevel	$T_j = 25^\circ\text{C}$	1.3	1.5	1.8	m Ω
		$T_j = 125^\circ\text{C}$	1.8	2.1	2.3	m Ω
I_{RRM}	$I_F = 450\text{ A}$	$T_j = 125^\circ\text{C}$		580		A
Q_{rr}	$di/dt_{off} = 8500\text{ A}/\mu\text{s}$	$T_j = 125^\circ\text{C}$		130		μC
E_{rr}	$V_{GE} = -15\text{ V}$	$T_j = 125^\circ\text{C}$		60		mJ
$R_{th(j-c)}$	per diode				0.11	K/W
	$V_{CC} = 600\text{ V}$	$T_j = 125^\circ\text{C}$				
Module						
L_{CE}				20		nH
R_{CC+EE}	res., terminal-chip	$T_C = 25^\circ\text{C}$		0.7		m Ω
		$T_C = 125^\circ\text{C}$		1		m Ω
$R_{th(c-s)}$	per module			0.04		K/W
M_s	to heat sink (M5)		3		5	Nm
M_t		to terminals (M6)	2.5		5	Nm
						Nm
w					300	g
Temperature Sensor						
R_{100}	$T_C=100^\circ\text{C}$ ($R_{25}=5\text{ k}\Omega$)			$493 \pm 5\%$		Ω
$B_{100/125}$	$R(T)=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]$; T[K];			$3550 \pm 2\%$		K



GAL

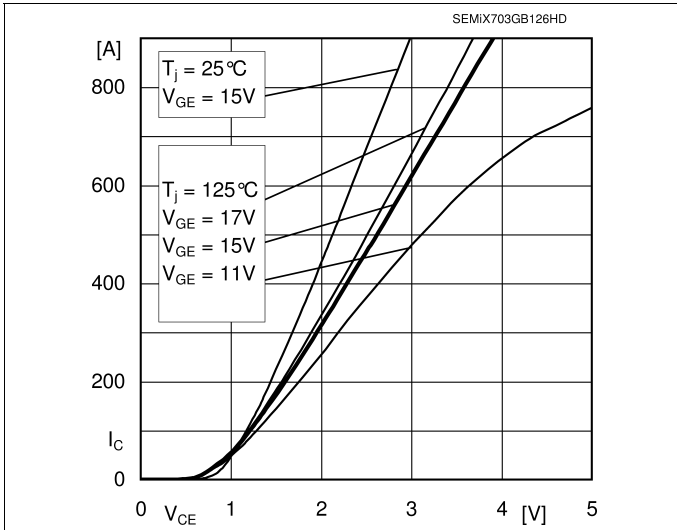


Fig. 1: Typ. output characteristic, inclusive R_{CC+EE}

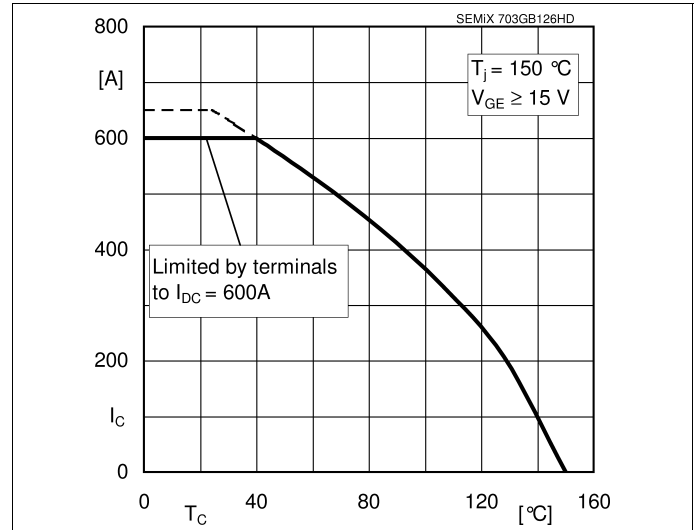


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

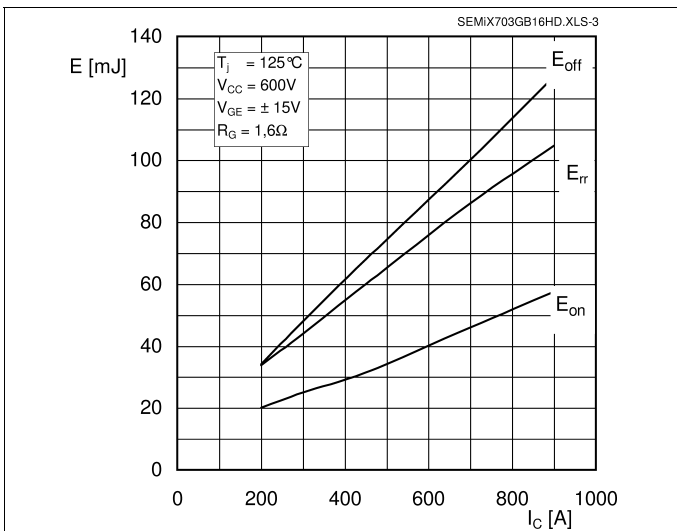


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

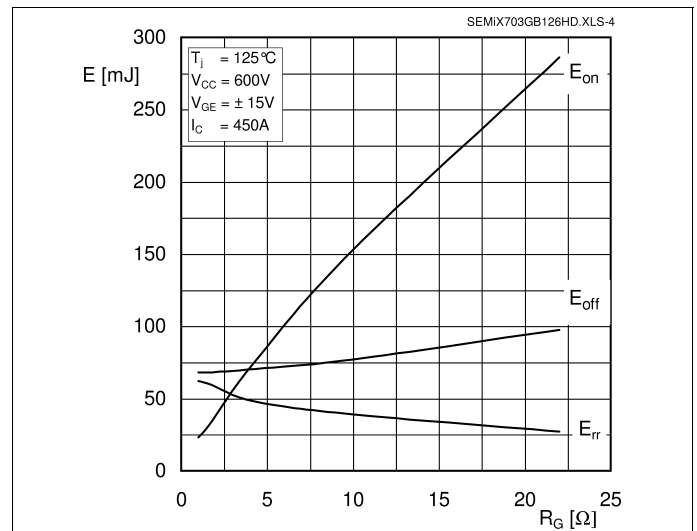


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

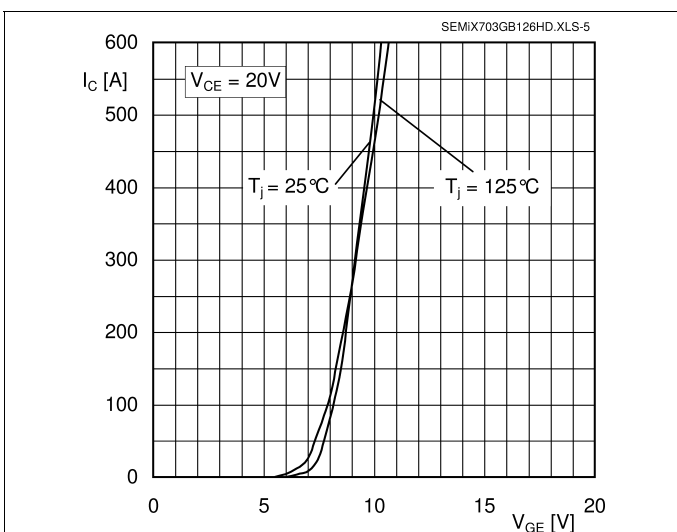


Fig. 5: Typ. transfer characteristic

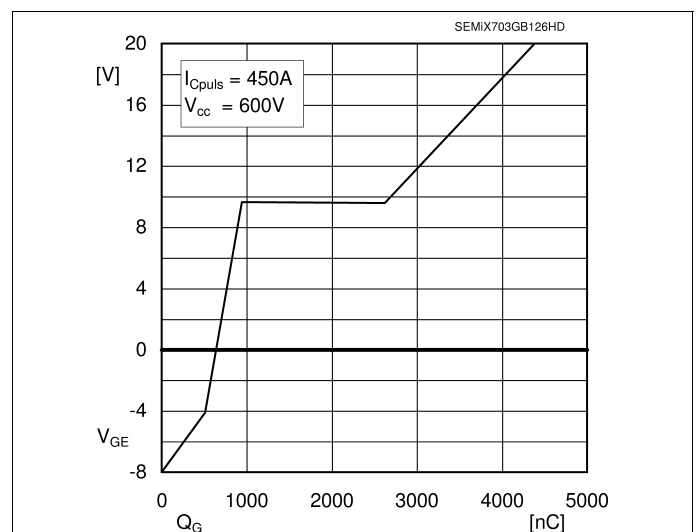


Fig. 6: Typ. gate charge characteristic

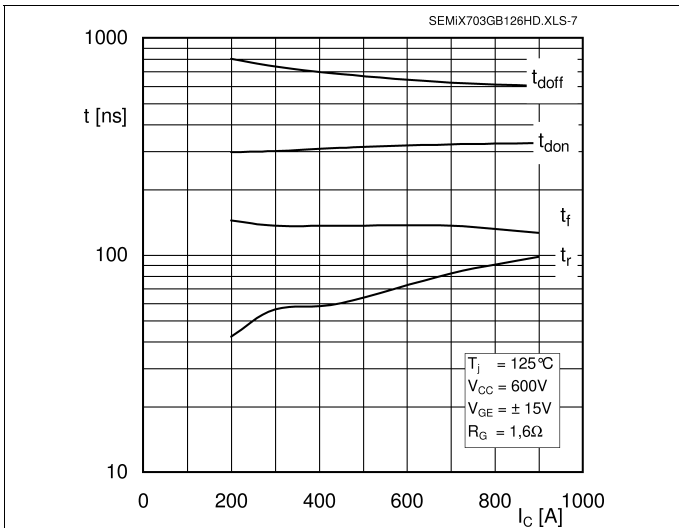


Fig. 7: Typ. switching times vs. I_C

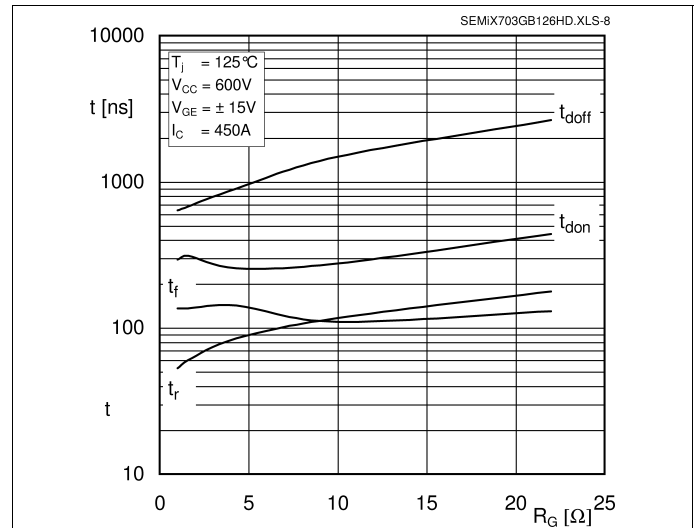


Fig. 8: Typ. switching times vs. gate resistor R_G

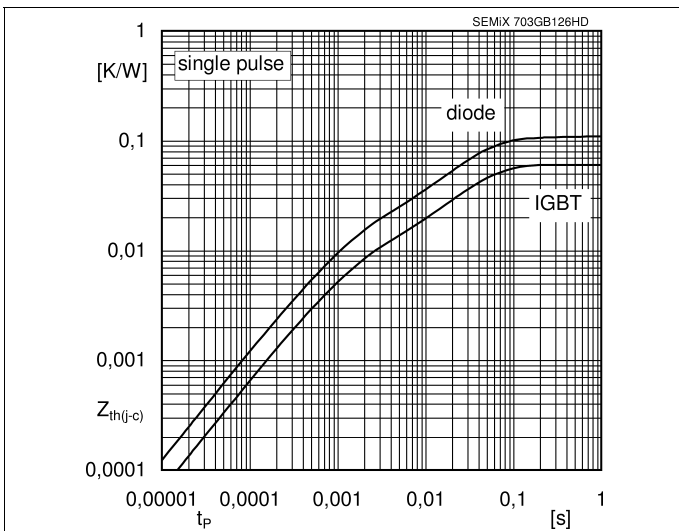


Fig. 9: Typ. transient thermal impedance

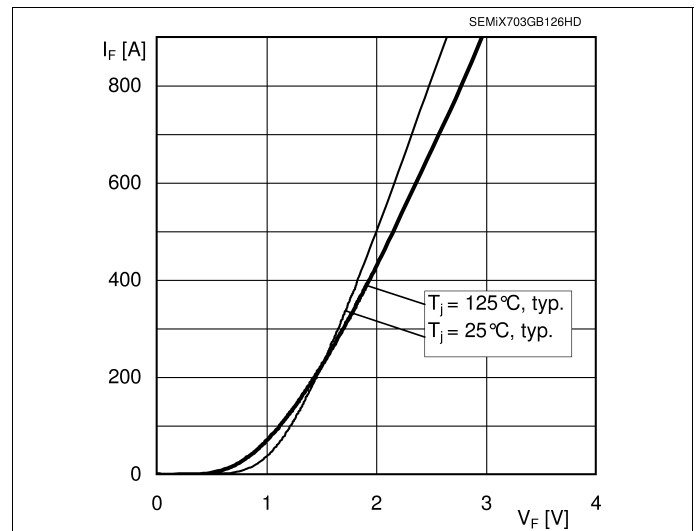


Fig. 10: Typ. CAL diode forward charact., incl. R_{CC+EE}

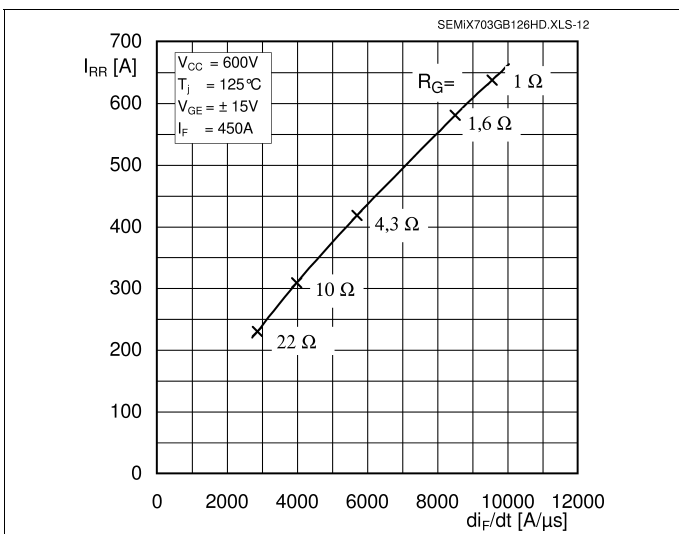


Fig. 11: Typ. CAL diode peak reverse recovery current

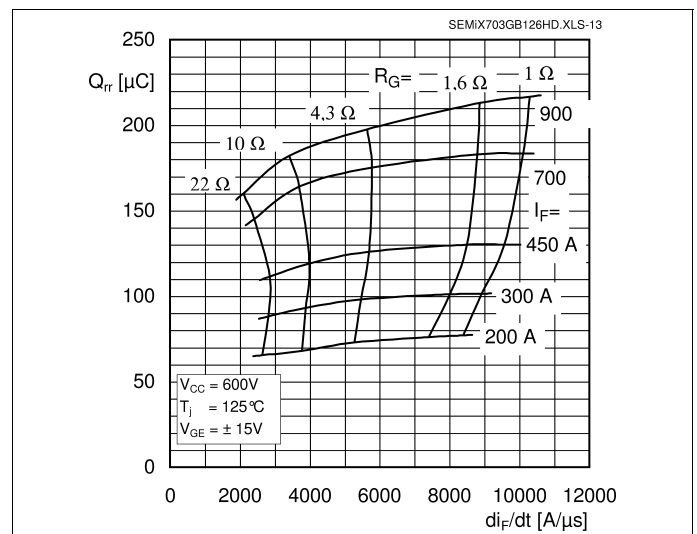
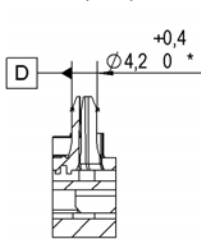


Fig. 12: Typ. CAL diode recovery charge

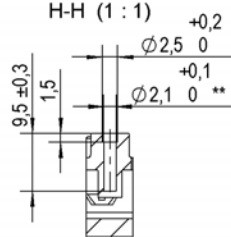
SEMiX703GAL126HDs

Case: SEMiX 3s

guide pin left
F-F (1 : 1)



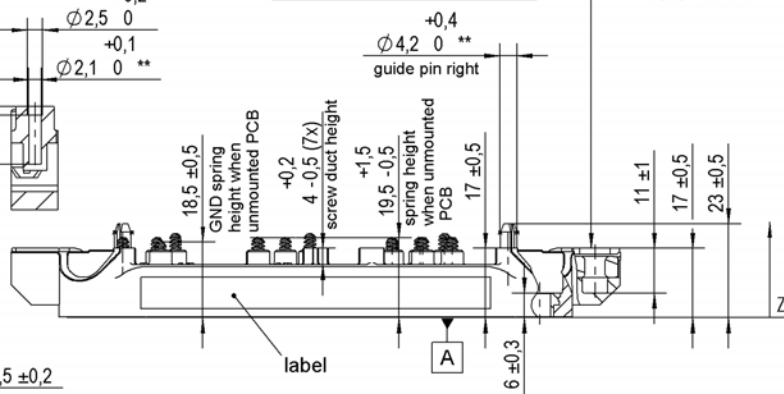
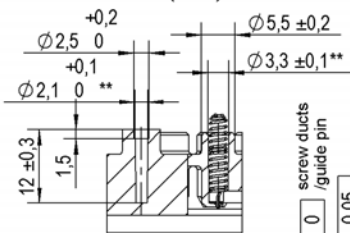
screw duct
(1x centre):
H-H (1 : 1)



	0,3	connector 1-2 / 3-4
	0,2	each connector

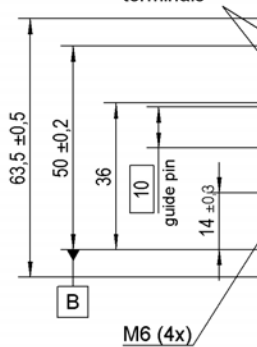
general tolerance:
ISO 2768-m
ISO 8015

screw duct (6x)
spring duct (16x):
G-G (1 : 1)

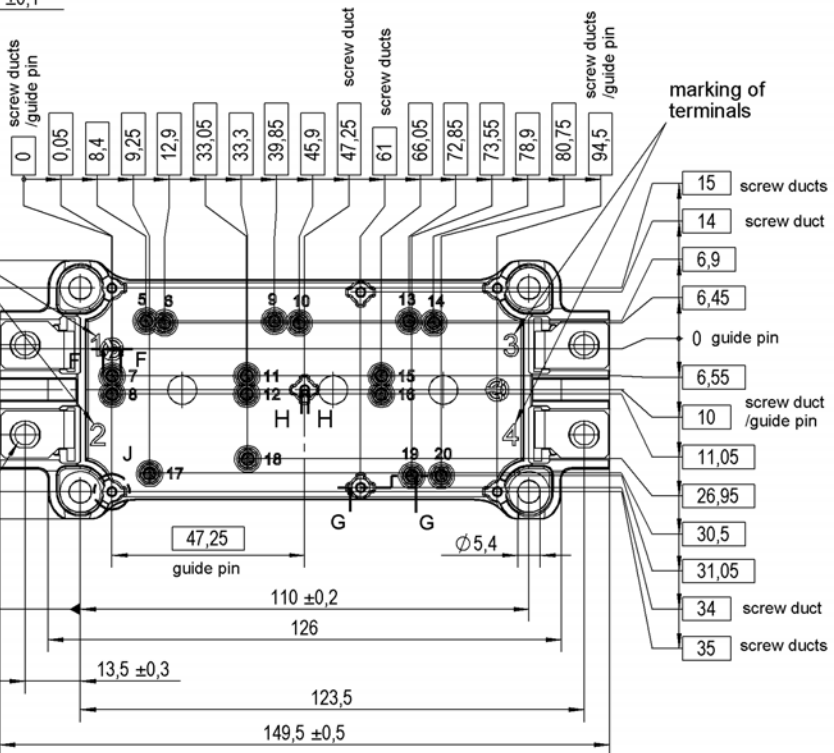
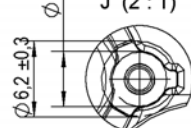


All measures in Z-direction
valid when mounted to heat sink

marking of
terminals



screw duct
top view(7x):
J (2 : 1)

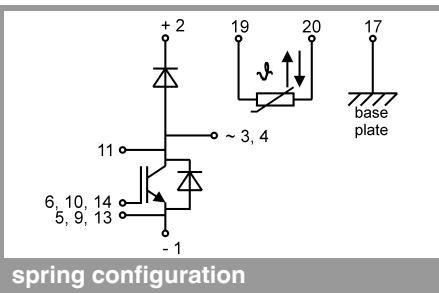


*guide pin left with
**screw ducts / spring ducts / guide pin right with

	0,25	A	B	C
	0,5	A	B	D

Rules for the contact PCB:
- holes guidepins = $\varnothing 4 \pm 0,1$ / position tolerance $\pm 0,1$
- holes for screws = $\varnothing 3,3 \pm 0,1$ / position tolerance $\pm 0,1$
- spring contact pad = $\varnothing 3,6 \pm 0,1$ / position tolerance $\pm 0,1$

SEMIX 3s



spring configuration

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.